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# STGW30NC60VD

40 A, 600 V, very fast IGBT with Ultrafast diode

## Features

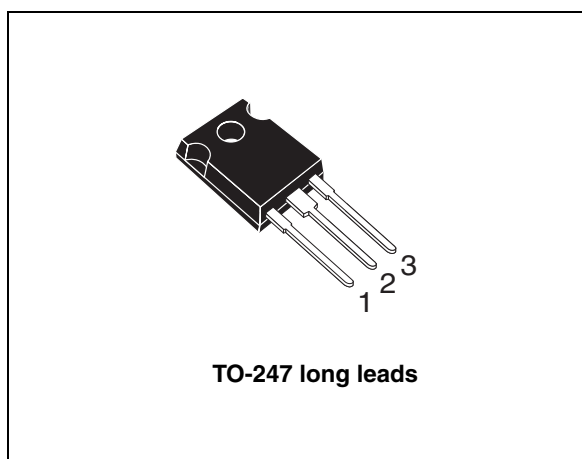
- High current capability
- High frequency operation up to 50 KHz
- Very soft ultra fast recovery antiparallel diode

## Applications

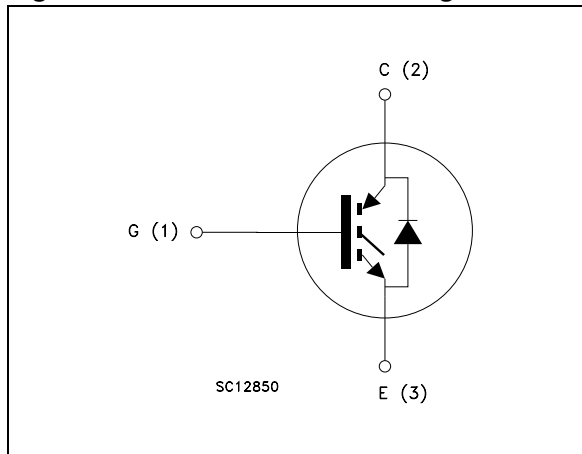
- High frequency inverters, UPS
- Motor drive
- SMPS and PFC in both hard switch and resonant topologies

## Description

This device utilizes the advanced Power MESH™ process resulting in an excellent trade-off between switching performance and low on-state behavior.



**Figure 1. Internal schematic diagram**



**Table 1. Device summary**

Order code	Marking	Package	Packaging
STGW30NC60VD	GW30NC60VD	TO-247 long leads	Tube

## Contents

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Electrical ratings

# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-emitter voltage (V <sub>GE</sub> = 0)	600	V
I <sub>C</sub> <sup>(1)</sup>	Continuous collector current at T <sub>C</sub> = 25 °C	80	A
I <sub>C</sub> <sup>(1)</sup>	Continuous collector current at T <sub>C</sub> = 100 °C	40	A
I <sub>CP</sub> <sup>(2)</sup>	Pulsed collector current	150	A
I <sub>CL</sub> <sup>(3)</sup>	Turn-off latching current	100	A
V <sub>GE</sub>	Gate-emitter voltage	± 20	V
I <sub>F</sub>	Diode RMS forward current at T <sub>C</sub> = 25 °C	30	A
I <sub>FSM</sub>	Surge not repetitive forward current t <sub>p</sub> = 10 ms sinusoidal	120	A
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	250	W
T <sub>J</sub>	Operating junction temperature	- 55 to 150	°C
T <sub>STG</sub>	Storage temperature		
T <sub>L</sub>	Maximum lead temperature for soldering purpose for 10 sec	300	°C

1. Calculated according to the iterative formula:

$$I_C(T_C) = \frac{T_{j(max)} - T_C}{R_{thj-c} \times V_{CE(sat)(max)}(T_{j(max)}, I_C(T_C))}$$

2. Pulse width limited by maximum junction temperature and turn-off within RBSOA

3. V<sub>clamp</sub> = 80 % V<sub>CES</sub>, T<sub>J</sub> = 150 °C, R<sub>G</sub> = 10 Ω, V<sub>GE</sub> = 15 V

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
R <sub>thJC</sub>	Thermal resistance junction-case IGBT	0.5	°C/W
	Thermal resistance junction-case diode	1.5	°C/W
R <sub>thJA</sub>	Thermal resistance junction-ambient	50	°C/W

Electrical characteristics

STGW30NC60VD

## 2 Electrical characteristics

T<sub>J</sub> = 25 °C unless otherwise specified.

**Table 4. Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V <sub>(BR)CES</sub>	Collector-emitter breakdown voltage (V <sub>GE</sub> = 0)	I <sub>C</sub> = 1 mA	600			V
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	V <sub>GE</sub> = 15 V, I <sub>C</sub> =20 A V <sub>GE</sub> = 15 V, I <sub>C</sub> =40 A V <sub>GE</sub> = 15 V, I <sub>C</sub> =80 A, T <sub>J</sub> =100 °C V <sub>GE</sub> = 15 V, I <sub>C</sub> =20 A, T <sub>J</sub> =125 °C		1.8 2.1 2.9 1.7	2.5	V
V <sub>GE(th)</sub>	Gate threshold voltage	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250 μA	3.75		5.75	V
I <sub>CES</sub>	Collector-cut-off current (V <sub>GE</sub> = 0)	V <sub>CE</sub> = 600 V V <sub>CE</sub> = 600 V, T <sub>J</sub> = 125 °C			10 1	μA mA
I <sub>GES</sub>	Gate-emitter leakage current (V <sub>CE</sub> = 0)	V <sub>GE</sub> = ± 20V			±100	nA
g <sub>fs</sub>	Forward transconductance	V <sub>CE</sub> = 15 V, I <sub>C</sub> = 20 A		15		S

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C <sub>ies</sub> C <sub>oes</sub> C <sub>res</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>CE</sub> = 25V, f = 1 MHz, V <sub>GE</sub> = 0	-	2200 225 50	-	pF pF pF
Q <sub>g</sub> Q <sub>ge</sub> Q <sub>gc</sub>	Total gate charge Gate-emitter charge Gate-collector charge	V <sub>CE</sub> = 390V, I <sub>C</sub> = 20A, V <sub>GE</sub> = 15V, (see Figure 18)	-	100 16 45	140	nC nC nC

**Table 6. Switching on/off (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> (di/dt) <sub>onf</sub>	Turn-on delay time Current rise time Turn-on current slope	V <sub>CC</sub> =390 V, I <sub>C</sub> = 20 A, R <sub>G</sub> =3.3 Ω, V <sub>GE</sub> =15V (see Figure 17)	-	31 11 1600	-	ns ns A/μs
t <sub>d(on)</sub> t <sub>r</sub> (di/dt) <sub>on</sub>	Turn-on delay time Current rise time Turn-on current slope	V <sub>CC</sub> =390 V, I <sub>C</sub> = 20 A, R <sub>G</sub> =3.3 Ω, V <sub>GE</sub> =15 V T <sub>J</sub> =125°C (see Figure 17)	-	31 11.5 1500	-	ns ns A/μs

**STGW30NC60VD**
**Electrical characteristics**
**Table 6. Switching on/off (inductive load)**

$t_{r(Voff)}$	Off voltage rise time	$V_{CC}=390\text{ V}$ , $I_C=20\text{ A}$ , $R_G=3.3\ \Omega$ , $V_{GE}=15\text{ V}$ (see Figure 17)	-	28	-	ns
$t_{d(off)}$	Turn-off delay time		-	100	-	ns
$t_f$	Current fall time		-	75	-	ns
$t_{r(Voff)}$	Off voltage rise time	$V_{CC}=390\text{ V}$ , $I_C=20\text{ A}$ , $R_G=3.3\ \Omega$ , $V_{GE}=15\text{ V}$ , $T_j=125^\circ\text{C}$ (see Figure 17)	-	66	-	ns
$t_{d(off)}$	Turn-off delay time		-	150	-	ns
$t_f$	Current fall time		-	130	-	ns

**Table 7. Switching energy (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$E_{on}^{(1)}$	Turn-on switching losses	$V_{CC}=390\text{ V}$ , $I_C=20\text{ A}$ , $R_G=3.3\ \Omega$ , $V_{GE}=15\text{ V}$ , (see Figure 19)	-	220	300	$\mu\text{J}$
$E_{off}$	Turn-off switching losses		-	330	450	$\mu\text{J}$
$E_{ts}$	Total switching losses		-	550	750	$\mu\text{J}$
$E_{on}^{(1)}$	Turn-on switching losses	$V_{CC}=390\text{ V}$ , $I_C=20\text{ A}$ , $R_G=3.3\ \Omega$ , $V_{GE}=15\text{ V}$ , $T_j=125^\circ\text{C}$ (see Figure 19)	-	450	-	$\mu\text{J}$
$E_{off}$	Turn-off switching losses		-	770	-	$\mu\text{J}$
$E_{ts}$	Total switching losses		-	1220	-	$\mu\text{J}$

1.  $E_{on}$  is the turn-on losses when a typical diode is used in the test circuit in Figure 19.  $E_{on}$  include diode recovery energy. If the IGBT is offered in a package with a co-pack diode, the co-pack diode is used as external diode. IGBTs & Diode are at the same temperature ( $25^\circ\text{C}$  and  $125^\circ\text{C}$ )

**Table 8. Collector-emitter diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_F$	Forward on-voltage	$I_F=20\text{ A}$ $I_F=20\text{ A}$ , $T_j=125^\circ\text{C}$	-	1.8 1.4	2.3	V V
$t_{rr}$	Reverse recovery time	$I_F=20\text{ A}$ , $V_R=40\text{ V}$ , $T_j=25^\circ\text{C}$ , $di/dt=100\text{ A}/\mu\text{s}$ (see Figure 20)	-	44	-	ns
$Q_{rr}$	Reverse recovery charge		-	66	-	nC
$I_{rrm}$	Reverse recovery current		-	3	-	A
$t_{rr}$	Reverse recovery time	$I_F=20\text{ A}$ , $V_R=40\text{ V}$ , $T_j=125^\circ\text{C}$ , $di/dt=100\text{ A}/\mu\text{s}$ (see Figure 20)	-	88	-	ns
$Q_{rr}$	Reverse recovery charge		-	237	-	nC
$I_{rrm}$	Reverse recovery current		-	5.4	-	A

Electrical characteristics

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2.1 Electrical characteristics (curves)

Figure 2. Output characteristics

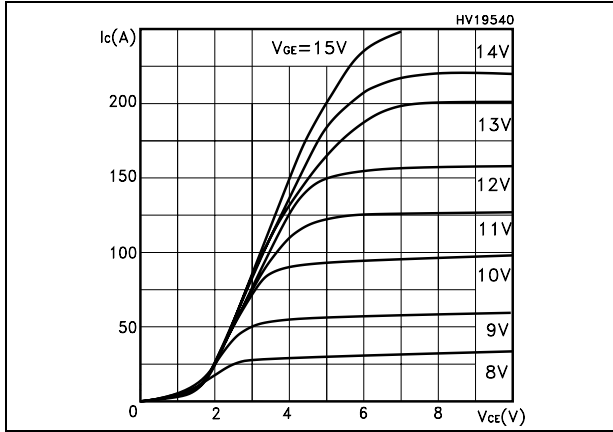


Figure 3. Transfer characteristics

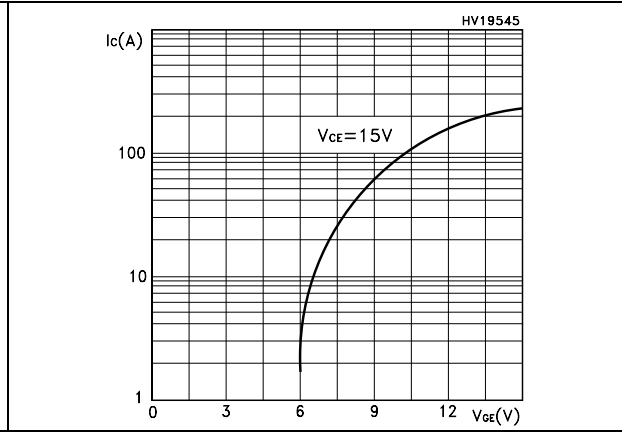


Figure 4. Trans conductance

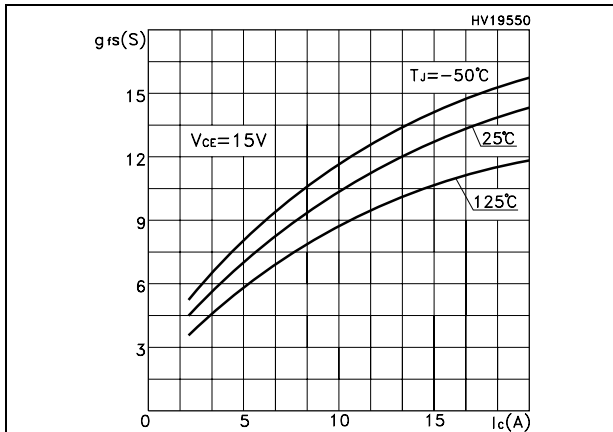


Figure 5. Collector-emitter on voltage vs temperature

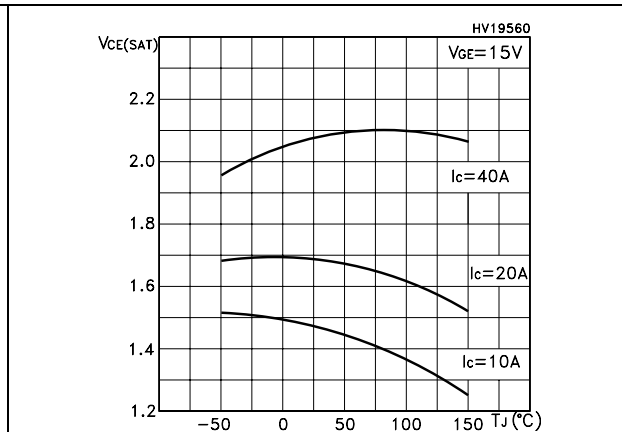


Figure 6. Collector-emitter on voltage vs collector current

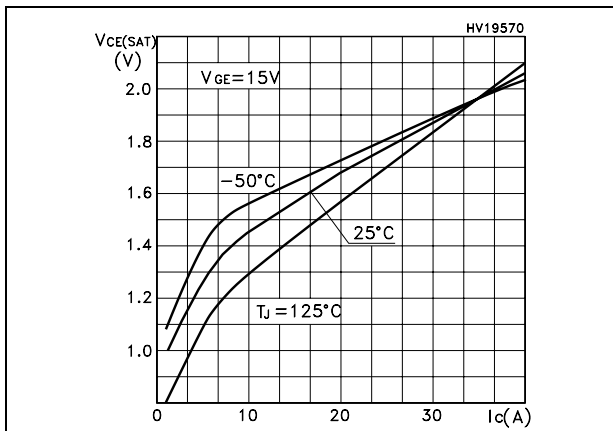
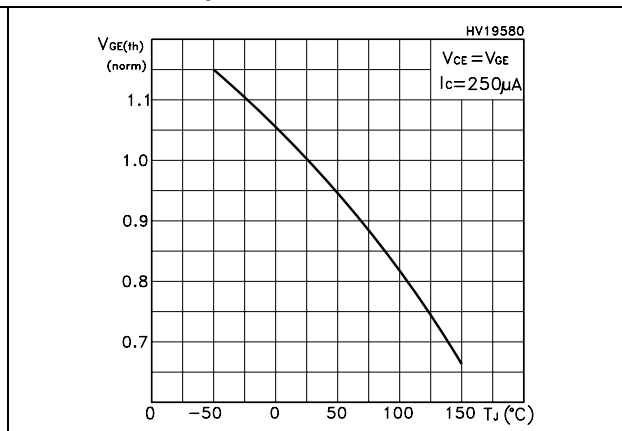


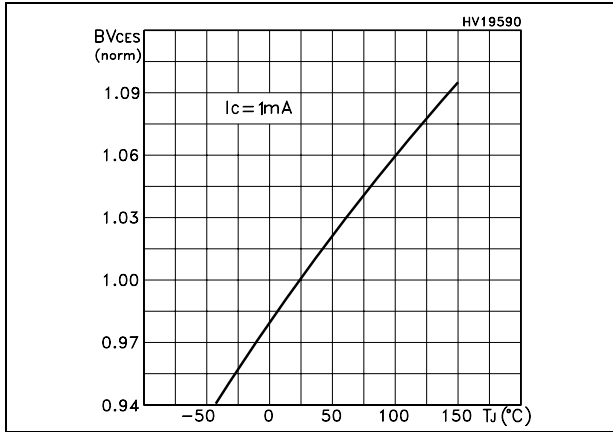
Figure 7. Normalized gate threshold vs temperature



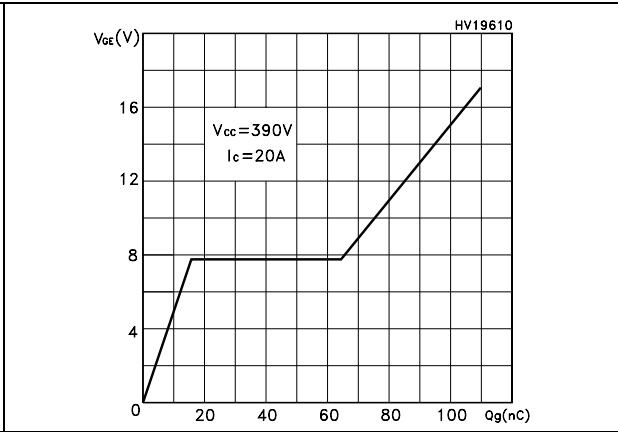
**STGW30NC60VD**

**Electrical characteristics**

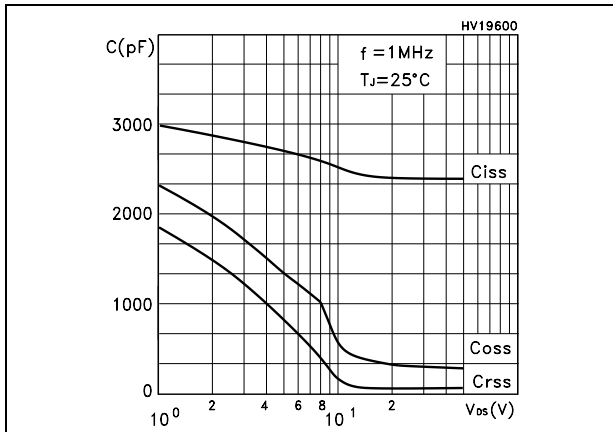
**Figure 8. Normalized breakdown voltage vs temperature**



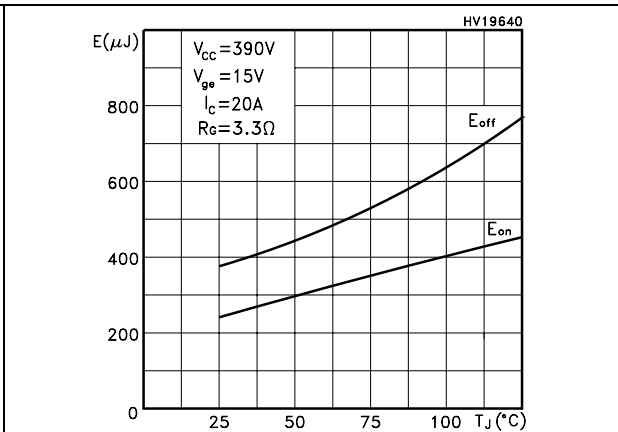
**Figure 9. Gate charge vs. gate-emitter voltage**



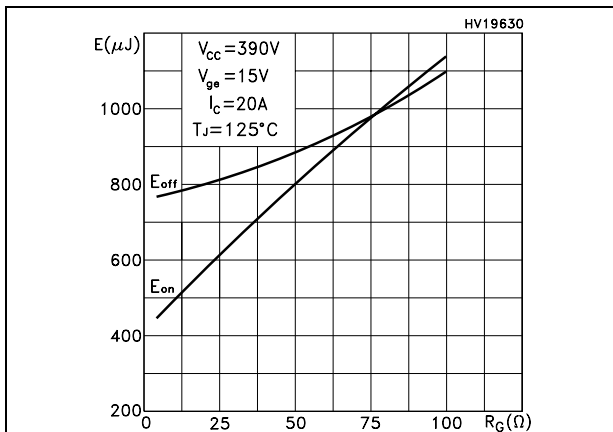
**Figure 10. Capacitance variations**



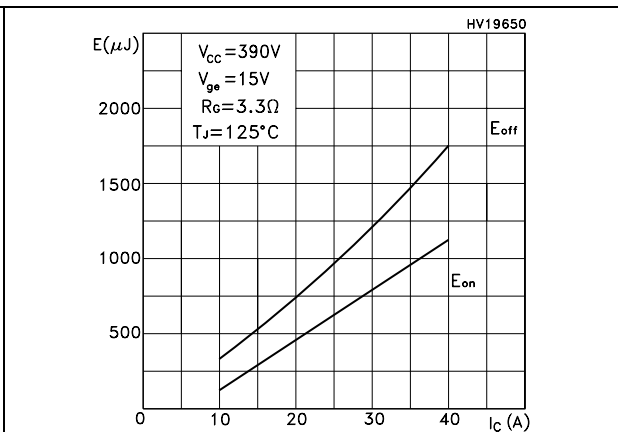
**Figure 11. Switching losses vs temperature**



**Figure 12. Switching losses vs. gate resistance**



**Figure 13. Switching losses vs collector current**

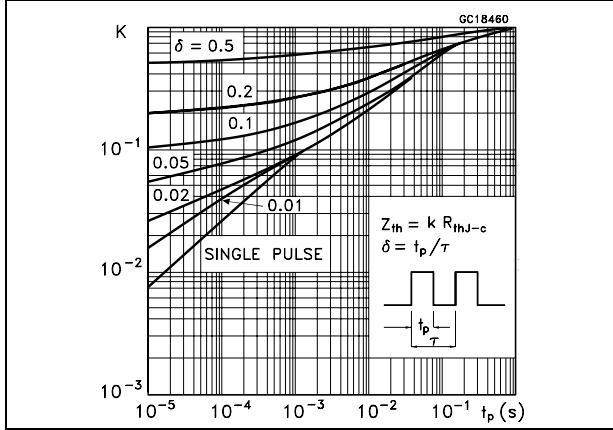




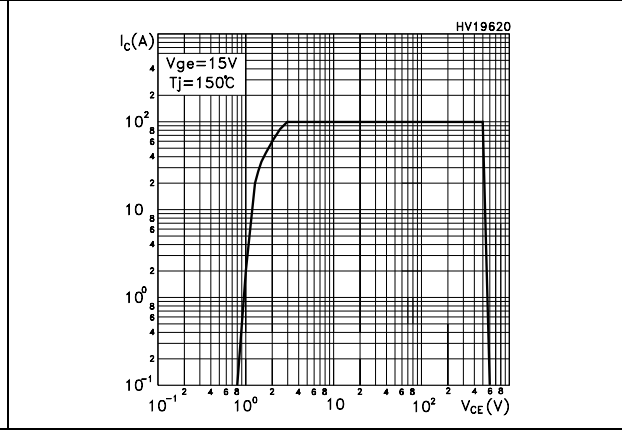
**Electrical characteristics**

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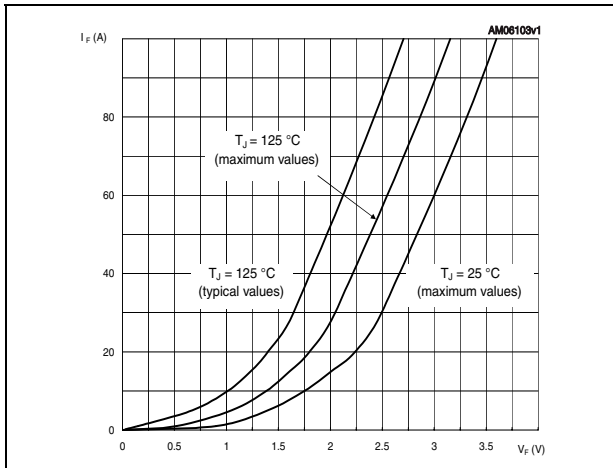
**Figure 14. Thermal impedance**



**Figure 15. Turn-off SOA**



**Figure 16. Emitter-collector diode characteristics**

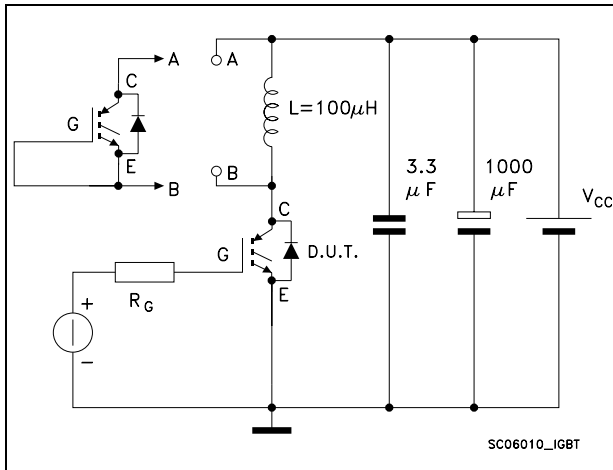


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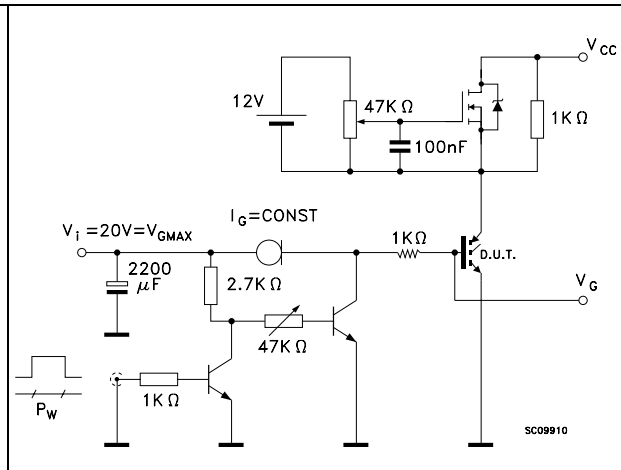
**Test circuits**

**3 Test circuits**

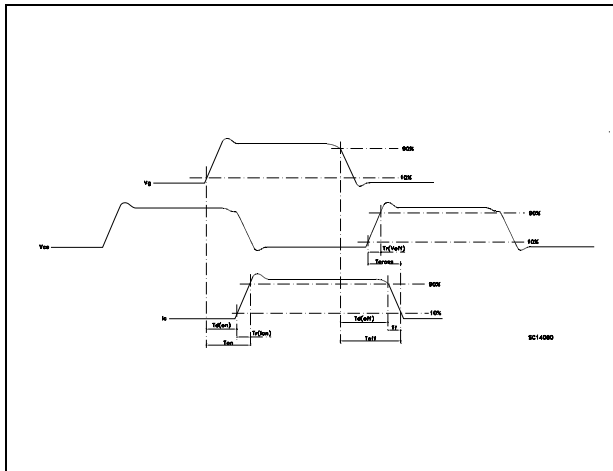
**Figure 17. Test circuit for inductive load switching**



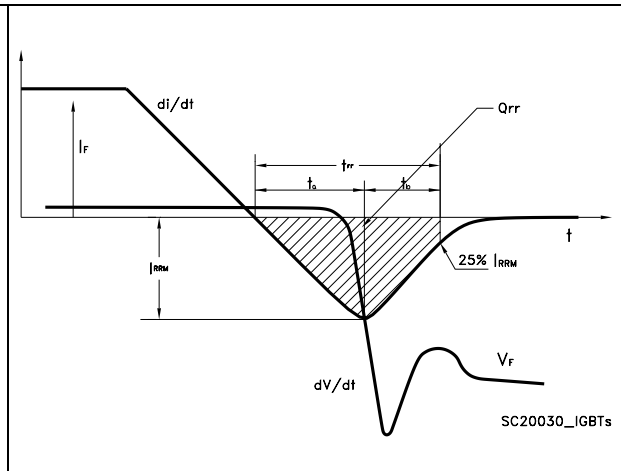
**Figure 18. Gate charge test circuit**



**Figure 19. Switching waveforms**



**Figure 20. Diode recovery times waveform**



## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

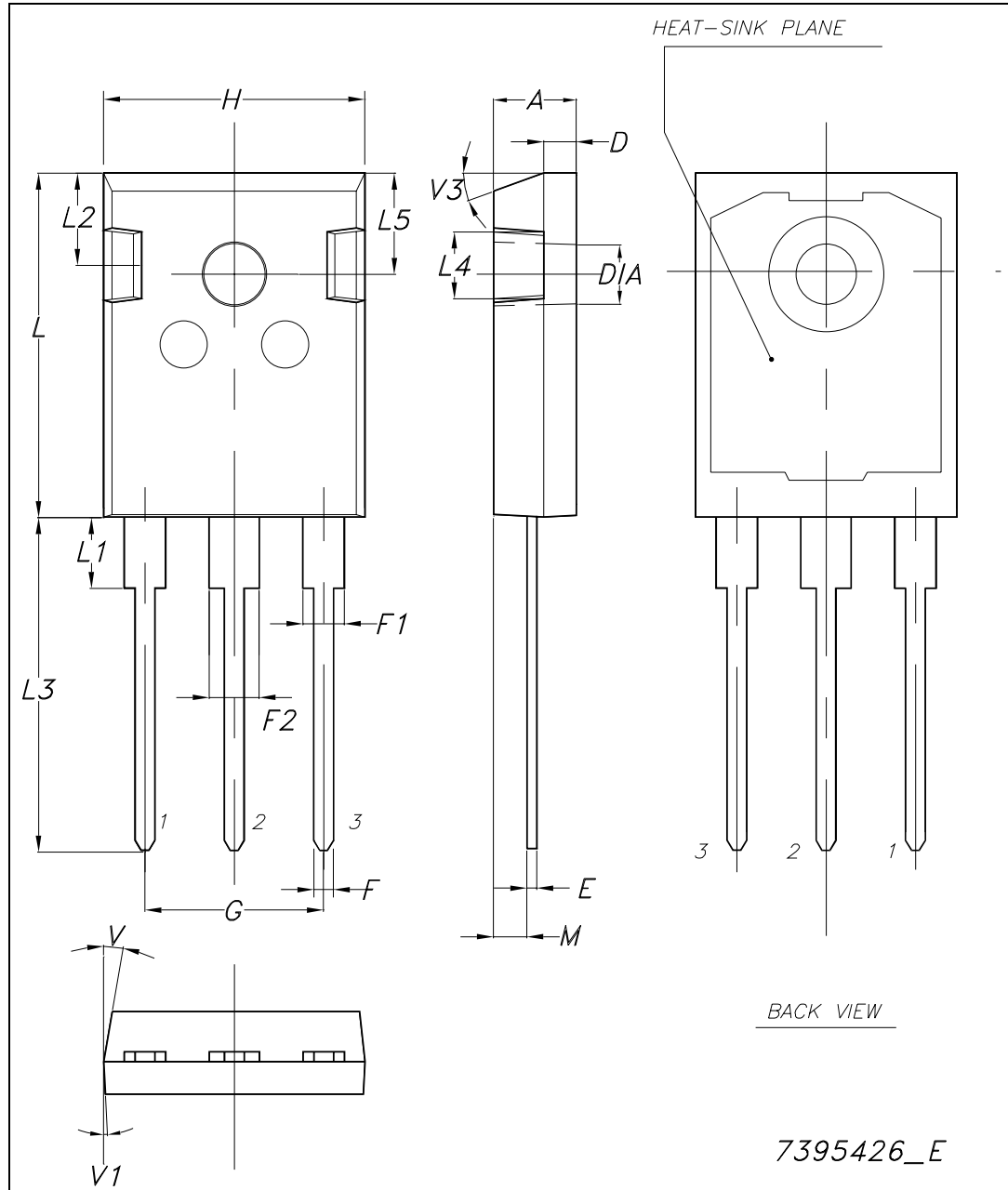
**Table 9. TO-247 long leads mechanical data**

Dim.	mm.		
	Min.	Typ.	Max.
A	4.90		5.15
D	1.85		2.10
E	0.55		0.67
F	1.07		1.32
F1	1.90		2.38
F2	2.87		3.38
G	10.90 BSC		
H	15.77		16.02
L	20.82		21.07
L1	4.16		4.47
L2	5.49		5.74
L3	20.05		20.30
L4	3.68		3.93
L5	6.04		6.29
M	2.27		2.52
V		10°	
V1		3°	
V3		20°	
Dia.	3.55		3.66

**STGW30NC60VD**

**Package mechanical data**

**Figure 21. TO-247 long leads drawing**



## 5 Revision history

**Table 10. Document revision history**

Date	Revision	Changes
12-Feb-2007	1	First release.
19-Feb-2007	2	<i>Figure 6</i> has been updated
12-Mar-2010	3	Inserted $I_{FSM}$ parameter on <i>Table 2: Absolute maximum ratings</i> . Updated <i>Figure 16: Emitter-collector diode characteristics</i> and package mechanical data.
03-Jan-2011	4	Updated <i>Table 4: Static</i> , <i>Table 8: Collector-emitter diode</i> and <i>Figure 14: Thermal impedance</i> .
23-Feb-2011	5	Added $T_L$ row <i>Table 2 on page 3</i> .

## STGW30NC60VD

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